

**Notice of References Cited**

Application/Control No.

10/722,369

Applicant(s)/Patent Under  
Reexamination  
HIRANO ET AL.

Examiner

ALAN MILLER

Art Unit

3624

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,737,728 A	04-1998	Sisley et al.	705/8
*	B	US-5,918,207 A	06-1999	McGovern et al.	705/1
*	C	US-2002/0052773 A1	05-2002	Kraemer et al.	705/9
*	D	US-6,438,353 B1	08-2002	Casey-Cholakias et al.	434/350
*	E	US-2002/0133389 A1	09-2002	Sinex, Barry	705/9
*	F	US-6,578,005 B1	06-2003	Lesaint et al.	705/8
*	G	US-2003/0130820 A1	07-2003	Lane, George H. III	702/184
*	H	US-2004/0088177 A1	05-2004	Travis et al.	705/001
*	I	US-6,850,895 B2	02-2005	Brodersen et al.	705/9
*	J	US-7,155,400 B1	12-2006	Jiik et al.	705/9
*	K	US-7,181,413 B2	02-2007	Hadden et al.	705/11
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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	V					
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	X					

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